

October 2014

FDMS8460

N-Channel Power Trench® MOSFET 40V, 49A, 2.2m Ω

Features

- Max $r_{DS(on)}$ = 2.2m Ω at V_{GS} = 10V, I_D = 25A
- Max $r_{DS(on)}$ = 3.0m Ω at V_{GS} = 4.5V, I_D = 21.7A
- Advanced Package and Silicon combination for low r_{DS(on)}
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

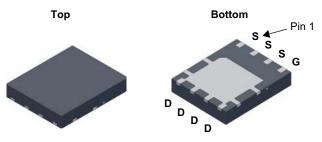


General Description

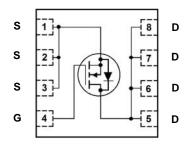
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process thant has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

■ DC - DC Conversion







MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			40	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25°C		49	
	-Continuous (Silicon limited)	T _C = 25°C		167	1 ,
ID	-Continuous	T _A = 25°C	(Note 1a)	25	A
	-Pulsed			160	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	864	mJ
Ъ	Power Dissipation	T _C = 25°C		104	W
P _D	Power Dissipation	T _A = 25°C	(Note 1a)	2.5] vv
T _J , T _{STG}	Operating and Storage Junction Temperature Ra	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8460	FDMS8460	Power 56	13"	12 mm	3000 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		32		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0V, V _{DS} = 32V,			1	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.9	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		-7.5		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10V, I _D = 25A		2.0	2.2	
		$V_{GS} = 4.5V, I_D = 21.7A$		2.6	3.0	mΩ
		V _{GS} = 10V, I _D = 25A, T _J = 125°C		2.6	3.3	
9 _{FS}	Forward Transconductance	$V_{DD} = 5V, I_{D} = 25A$		137		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 20V, V _{GS} = 0V, f = 1MHz		5415	7205	pF
C _{oss}	Output Capacitance			1470	1955	pF
C _{rss}	Reverse Transfer Capacitance			170	250	pF
R_g	Gate Resistance	f = 1MHz	0.1	1.4	3.1	Ω

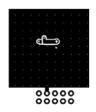
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		19	35	ns
t _r	Rise Time	V _{DD} = 20V, I _D = 25A,	9	19	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6\Omega$	48	78	ns
t _f	Fall Time		7	14	ns
Q_g	Total Gate Charge	V _{GS} = 0V to 10V	78	110	nC
Qg	Total Gate Charge	$V_{GS} = 0V \text{ to } 4.5V V_{DD} = 20V,$	36	51	nC
Q _{gs}	Gate to Source Charge	I _D = 25A	15		nC
Q_{gd}	Gate to Drain "Miller" Charge		10		nC

Drain-Source Diode Characteristics

V _{SD} Source to Drain Diode Forward Voltage	Source to Drain Diede Fenyard Voltage	$V_{GS} = 0V, I_S = 25A$ (Note 2)	0.8	1.3	\/
	Source to Drain Diode Torward Voltage	$V_{GS} = 0V, I_S = 2.1A$ (Note 2))	0.7	1.2	\ \
t _{rr}	Reverse Recovery Time	I _F = 25A, di/dt = 100A/μs		53	85	ns
Q _{rr}	Reverse Recovery Charge	- 1 _F - 25A, αι/αι - 100A/μs		40	64	nC

^{1.} R_{0,1A} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,1C} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a. 50°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125°C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.

^{3.} Starting T_J = 25°C, L = 3mH, I_{AS} = 24A, V_{DD} = 40V, V_{GS} = 10V

Typical Characteristics T_J = 25°C unless otherwise noted

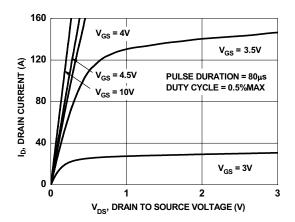


Figure 1. On-Region Characteristics

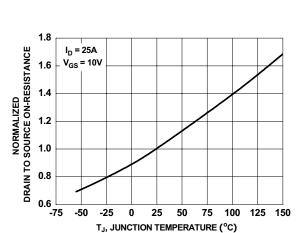


Figure 3. Normalized On-Resistance vs Junction Temperature

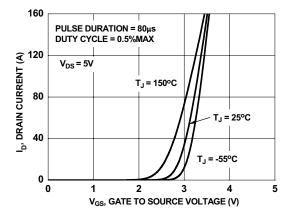


Figure 5. Transfer Characteristics

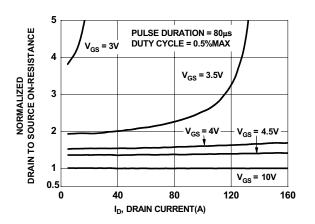


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

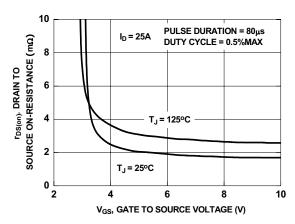


Figure 4. On-Resistance vs Gate to Source Voltage

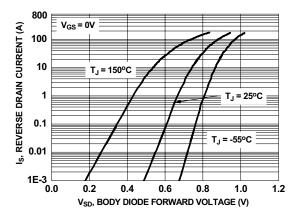


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

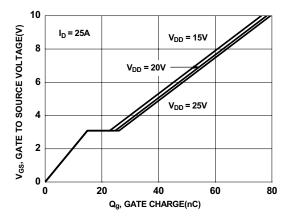


Figure 7. Gate Charge Characteristics

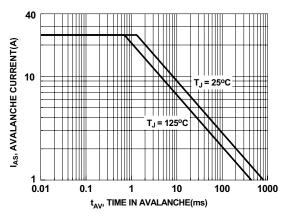


Figure 9. Unclamped Inductive Switching Capability

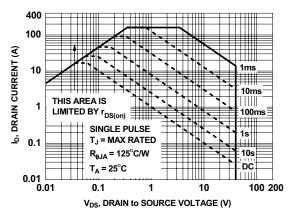


Figure 11. Forward Bias Safe Operating Area

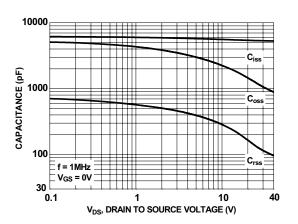


Figure 8. Capacitance vs Drain to Source Voltage

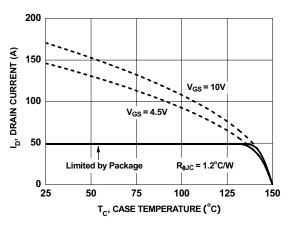


Figure 10. Maximum Continuous Drain Current vs Case Temperature

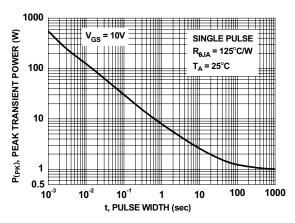


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

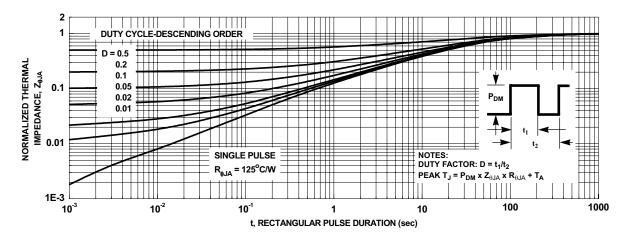


Figure 13. Transient Thermal Response Curve



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